

Notic of References Cited	Application/Control No. 10/042,976	Applicant(s)/Patent Under Reexamination SKUTNIK, BOLESH J.	
	Examiner <i>John D. Lee</i> John D. Lee	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,684,907	11-1997	Sprehn et al.	385/123
	B	US-5,807,607	09-1998	Smith et al.	438/758
	C	US-6,124,191	09-2000	Bohr, Mark T.	438/595
	D	US-6,469,390	10-2002	Chang et al.	257/758
	E	US-6,154,595	11-2000	Yokogawa et al.	385/127
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	11-84136	03-1999	Japan	Yabunouchi et al.	G02B 6/00
	O	2000-137119	05-2000	Japan	Yokogawa et al.	G02B 6/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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